

**Search Notes**

Application/Control No.

10/733,763

Examiner

X. L. Bautista

Applicant(s)/Patent under  
Reexamination

KIRN ET AL.

Art Unit

2179

**SEARCHED**

Class	Subclass	Date	Examiner
same as	prior search	11/17/2006	XB

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Search	11/17/2006	XB
Databases Searched: US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB		
Dialog Search		
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